Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/055,197	LIFSHITZ ET AL.
Examiner	Art Unit

2611

Jason M. Perilla

SEARCHED				
Class	Subclass	Date	Examiner	
375	222	12/18/2006	JP	
	219	12/18/2006	JP	
	295	12/18/2006	JP	
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East USPAT/USPGPUB EPO/JPO	12/18/2006	JP
Inventor Name Search EAST/EDAN	12/18/2006	JP
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